

EAST Search History**EAST Search History (Prior Art)**

| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|-------|--------|---|-------------------------------|------------------|---------|------------------|
| S1 | 5 | ("20040145056" "5050838" "6020215" "6162367" "6706548").PN. | US-PGPUB; USPAT | ADJ | ON | 2008/12/06 10:14 |
| S2 | 16 | ((JOZEF) near2 ("VAN BEEK")).INV. | US-PGPUB; USPAT; USOCR | ADJ | ON | 2008/12/06 10:15 |
| S3 | 32 | ((JOZEF) near2 ("VAN BEEK")).INV. | EPO; JPO; DERWENT | ADJ | ON | 2008/12/06 10:15 |
| S4 | 5 | ((MATHIEU) near2 (ULENAERS)).INV. | US-PGPUB; USPAT; USOCR | ADJ | ON | 2008/12/06 10:15 |
| S5 | 5 | ((MATHIEU) near2 (ULENAERS)).INV. | EPO; JPO; DERWENT | ADJ | ON | 2008/12/06 10:15 |
| S6 | 11805 | mems and fluori\$3 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 13:11 |
| S7 | 781 | mems and (fluori\$3 with layer with (remov\$3 or etch\$3 or sacrific\$4)) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 13:12 |
| S8 | 0 | S7 and "257".cls. | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 13:12 |
| S9 | 173 | S7 and "257".clas. | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 13:12 |
| S10 | 263 | S7 and "438".clas. | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 13:13 |
| S11 | 47 | (S9 or S10) and (mem or mems).ti. | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 13:16 |
| S13 | 16702 | mems.ti,ab. | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 17:33 |
| S14 | 189856 | silicon substrate | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 17:34 |
| S16 | 509030 | (insulat\$3 or etch\$5 or oxid\$5) layer | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 17:35 |
| S17 | 457582 | fluroine or fluoride or hf or hydrofluori\$3 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 17:35 |

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|-----|-------|---|-------------------------------------|-----|----|---------------------|
| S18 | 2162 | S13 and S14 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 17:36 |
| S19 | 1030 | S18 and S16 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 17:36 |
| S20 | 468 | S19 and S17 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 17:36 |
| S21 | 9760 | (fluroine or fluoride or hf or hydrofluori\$3) same (dry near3 etch\$3) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 17:37 |
| S22 | 66 | S13 AND S14 AND S16 and S21 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 17:37 |
| S23 | 14009 | (fluorine or fluoride or hf or hydrofluori\$3) same (dry near3 etch\$3) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 17:39 |
| S24 | 73 | S13 AND S14 AND S16 and S23 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/07 17:39 |
| S25 | 1009 | 257/417.ccls. | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 10:22 |
| S26 | 132 | (mem or mems) and S25 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 10:25 |
| S27 | 121 | S26 and substrate | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 10:26 |
| S28 | 1009 | 257/417.ccls. | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 13:46 |
| S29 | 132 | (mem or mems) and S28 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 13:46 |
| S30 | 83 | S29 and silicon near3 substrate | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 13:46 |
| S31 | 83 | S29 and (silicon near3 substrate) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 13:46 |

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| S32 | 30 | ("5015850" "5210714" "5226321" "5265470" "5313835" "5354985" "5475318" "5659195" "5665253" "5666190" "5747804" "5883387" "5894090" "5929497" "5994750" "6075585" "6091125" "6092423" "6174820" "6211532" "6229190" "6296779" "6337027").PN. OR ("6580138").URPN. | US-PGPUB; USPAT; USOCR | ADJ | ON | 2008/12/08 14:12 |
| S33 | 76947 | ((etch stop) or oxide) near4 layer near4 substrate | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 14:15 |
| S34 | 21291 | S33 and metal oxide | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 14:15 |
| S35 | 222251 | hf\$6 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 14:16 |
| S36 | 11009 | "hfo.sub.2" | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 14:16 |
| S37 | 2254 | S33 and S36 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 14:16 |
| S38 | 85240 | (mem or mems) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 14:17 |
| S39 | 2572 | S33 and S38 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 14:17 |
| S40 | 677 | S39 and metal oxide | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 14:17 |
| S41 | 65 | S39 and S36 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 14:17 |
| S42 | 1 | ("6809394").PN. | US-PGPUB; USPAT; USOCR | OR | OFF | 2008/12/08 14:19 |
| S43 | 61 | "al.sub.3O.sub.3" | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 14:22 |
| S44 | 0 | S43 and S39 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/08 14:22 |
| S45 | 1010 | 257/417.ccls. | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/09 09:31 |

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| S46 | 132 | (mem or mems) and S45 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2008/12/09 09:31 |
| S47 | 1 | ("20070222007").PN. | US-PGPUB; USPAT; USOCR | OR | OFF | 2008/12/09 10:58 |
| S48 | 1 | ("6621280").PN. | US-PGPUB; USPAT; USOCR | OR | OFF | 2008/12/10 14:04 |
| S49 | 14857 | (silicon near3 substrate) and ("al.sub.2O.sub.3" or "HfO.sub.2" or "Zro. SUB.2" OR "T1O.sub.2") | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/23 09:44 |
| S50 | 1222 | S49 and etch stop | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/23 09:44 |
| S51 | 2 | (silicon near3 substrate) and (("al.sub.2O.sub.3" or "HfO.sub.2" or "Zro. SUB.2" OR "T1O.sub.2") near5 etch stop) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/23 09:50 |
| S52 | 90 | (silicon near3 substrate) and (("al.sub.2O.sub.3" or "HfO.sub.2" or "Zro. SUB.2" OR "T1O.sub.2") with etch stop) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/23 09:52 |
| S53 | 3 | ("20020031711") or ("20020117752") or ("20030003641").PN. | US-PGPUB; USPAT; USOCR | OR | OFF | 2009/02/24 09:03 |
| S54 | 90363 | mem or (micro adj electromechanic\$4) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/24 10:00 |
| S55 | 90 | (silicon near3 substrate) and (("al.sub.2O.sub.3" or "HfO.sub.2" or "Zro. SUB.2" OR "T1O.sub.2") with etch stop) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/24 10:00 |
| S56 | 6 | S54 and S55 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/24 10:00 |
| S57 | 50802 | sacrific\$7 near3 (film or layer or substrate or material) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/24 14:08 |
| S58 | 647 | S57 and "439".clas. | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/24 14:10 |
| S59 | 45 | S58 and (mems or bistable adj switch or voltage adj switch) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/24 14:10 |
| S60 | 201 | (("al.sub.2O.sub.3" or "HfO.sub.2" or "Zro. SUB.2" OR "T1O.sub.2") with etch stop) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/24 14:11 |

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|-----|-------|--|-------------------------------------|-----|----|---------------------|
| S61 | 0 | S58 and S60 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/24 14:11 |
| S62 | 647 | S57 and S58 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/24 14:11 |
| S63 | 44 | S57 and S60 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/02/24 14:11 |
| S64 | 13 | ("2001/0005631").URPN. | USPAT | ADJ | ON | 2009/02/24 14:14 |
| S67 | 2 | (etch\$4 near2 stop) with ("hfo.sub.2" or "zro.sub.2" or "Tio.sub.2") and (MEMS or movable electrode) | US-PGPUB; USPAT | ADJ | ON | 2009/08/31 14:28 |
| S68 | 1420 | ("hfo.sub.2" or "zro.sub.2" or "Tio.sub.2") and (MEMS or movable electrode) | US-PGPUB; USPAT | ADJ | ON | 2009/08/31 14:28 |
| S69 | 248 | ((("hfo.sub.2" or "zro. sub.2" or "Tio.sub.2") with substrate) and (MEMS or movable electrode) | US-PGPUB; USPAT | ADJ | ON | 2009/08/31 14:29 |
| S70 | 10 | ((("hfo.sub.2" or "zro. sub.2" or "Tio.sub.2") with substrate) and (movable electrode) | US-PGPUB; USPAT | ADJ | ON | 2009/08/31 14:32 |
| S71 | 53 | ("hfo.sub.2" or "zro.sub.2" or "Tio.sub.2") and (movable electrode) | US-PGPUB; USPAT | ADJ | ON | 2009/08/31 14:34 |
| S72 | 43 | S71 not S70 | US-PGPUB; USPAT | ADJ | ON | 2009/08/31 14:34 |
| S73 | 13055 | ("hfo.sub.2" or "zro.sub.2" or "Tio.sub.2") and dielectric layer | US-PGPUB; USPAT | ADJ | ON | 2009/08/31 14:40 |
| S74 | 375 | S73 and mems | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/08/31 14:41 |
| S75 | 104 | S74 and "438".clas. | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/08/31 14:41 |
| S76 | 5373 | ("hfo.sub.2" or "zro.sub.2" or "Tio.sub.2") same dielectric layer | US-PGPUB; USPAT | ADJ | ON | 2009/08/31 14:41 |
| S77 | 107 | S76 and mems | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/08/31 14:41 |
| S78 | 0 | (10/302349).APP. | USPAT; USOCR | ADJ | ON | 2009/08/31 14:44 |
| S79 | 1 | ("2003/0146463").URPN. | USPAT | ADJ | ON | 2009/08/31 14:45 |

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| S80 | 5373 | ("hfo.sub.2" or "zro.sub.2" or "Tio.sub.2") same dielectric layer | US-PGPUB; USPAT | ADJ | ON | 2009/08/31 16:55 |
| S81 | 107 | S80 and mems | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/08/31 16:55 |
| S82 | 38 | S81 and (etch near3 stop \$4) | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/08/31 16:55 |
| S83 | 166 | ("hfo.sub.2" or "zro.sub.2" or "Tio.sub.2") with (etch near3 stop\$4) | US-PGPUB; USPAT | ADJ | ON | 2009/08/31 16:59 |
| S84 | 3 | (("5972722") or ("6211035") or ("20010055852")).PN. | US-PGPUB; USPAT; USOCR | OR | OFF | 2009/08/31 17:08 |
| S85 | 12725 | (fluorine or fluoride or hf) near4 plasma | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/12/15 06:23 |
| S86 | 60902 | (MEMS or movable electrode) and substrate | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/12/15 06:23 |
| S87 | 670 | S85 and S86 | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/12/15 06:23 |
| S88 | 195 | S87 and "438".clas. | US-PGPUB; USPAT; JPO; DERWENT | ADJ | ON | 2009/12/15 06:23 |

EAST Search History (Interference)

| Ref # | Hits | Search Query | DBs | Default Operator | Plurals | Time Stamp |
|-------|-------|--|-------------|------------------|---------|------------------|
| S89 | 6 | ((JOZEF) near2 ("VAN BEEK")).INV. | USPAT; UPAD | ADJ | ON | 2009/12/15 06:17 |
| S90 | 4 | ((MATHIEU) near2 (ULENAERS)).INV. | USPAT; UPAD | ADJ | ON | 2009/12/15 06:17 |
| S91 | 5457 | (fluorine or fluoride or hf) near4 plasma | USPAT; UPAD | ADJ | ON | 2009/12/15 06:19 |
| S92 | 24073 | (MEMS or movable electrode) and substrate | USPAT; UPAD | ADJ | ON | 2009/12/15 06:20 |
| S93 | 298 | S91 and S92 | USPAT; UPAD | ADJ | ON | 2009/12/15 06:20 |
| S94 | 103 | S93 and "438".clas. | USPAT; UPAD | ADJ | ON | 2009/12/15 06:21 |
| S95 | 871 | ((fluorine or fluoride or hf) near4 plasma).clm. | USPAT; UPAD | ADJ | ON | 2009/12/15 06:22 |
| S96 | 1831 | ((MEMS or movable electrode) and substrate).clm. | USPAT; UPAD | ADJ | ON | 2009/12/15 06:22 |

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|-----|----|---|----------------|-----|----|------------------|
| S97 | 2 | S95 and S96 | USPAT; UPAD | ADJ | ON | 2009/12/15 06:22 |
| S98 | 34 | ((fluorine or fluoride or hf) near4 plasma) and etch stop).clm. | USPAT; UPAD | ADJ | ON | 2009/12/15 06:23 |

12/ 15/ 2009 6:24:30 AM

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